Probing Liquid Surfaces and Interfaces Using Time-of-Flight Secondary Ion Mass Spectrometry

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The surfaces of aqueous phases and films can have unique kinetics and thermodynamics, distinct from the bulk. However, major surface analytical techniques are mostly vacuum-based and direct applications for volatile liquid studies are difficult. We developed a vacuum compatible microfluidic interface to enable surface analysis of liquids and liquid-solid interactions. The unique aspect of our approach is that 1) the detection window is an aperture of 2-3 μm in diameter, which allows direct detection of the liquid surface, and 2) it uses surface tension to hold the liquid within the aperture. The microfluidic reactor is composed of a silicon nitride (SiN) membrane and polydimethylsiloxane (PDMS) [1, 2]. Its application in ToF-SIMS as an analytical tool was evaluated. Most recently, we demonstrated in situ probing of the electrode-electrolyte solution interface using a new electrochemical probe based on our original invention. It provides direct observation of the surface and diffused layer with chemical speciation in liquids using ToF-SIMS for the first time. Moreover, we extended the microfluidic reactor for biofilm growth and real-time characterization. Our results provided the first ToF-SIMS molecular imaging of the hydrated biofilm using this unique capability.

A ToF-SIMS V spectrometer (IONTOF GmbH, Münster, Germany) was used in these experiments. A pulsed 25 keV Bi⁺ (beam size: ~250 nm) ion beam with an incident angle of 45 degree off the normal was used as the primary ion beam for all measurements. The SIMS measurements were performed at the beam current of ~1.0 pA with a beam width of 130 ns and a repeated frequency of 20 kHz. The main chamber vacuum pressure was 2-4×10⁻⁶ mbar with our device inside the chamber, and the pressure only slightly increased to 3-5×10⁻⁶ mbar during measurements. This indicates that no spraying or fast spreading of aqueous solutions occurs through the aperture.

Figure 1 depicts the latest results from the first electrode-electrolyte solution interface observation using in situ ToF-SIMS. The electrolyte is a dilute KI solution. The three electrode electrochemical system consists of a gold (Au) working electrode, a platinum (Pt) counter electrode and a Pt reference electrode. Figure 2 depicts the first in situ hydrated biofilm SIMS m/z spectrum and 2D images of selected fatty acids (FA) fragments, which confirms the molecular imaging of biofilm in addition to in situ confocal scanning laser spectroscopy observations of biofilm growth. These new results demonstrated technical
advancements of conducting chemical imaging of liquid-solid interface in situ in their native liquid environment using surface sensitive characterization tools [3].

References:

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Figure 1. (a) The cyclic voltammogram for the polycrystalline Au electrode in a 10 mM KI electrolyte solution. (b) ToF-SIMS m/z spectra acquired at different potentials. Only m/z peaks of interest are shown. (c) Normalized intensity from the m/z spectra obtained in ToF-SIMS as a function of potential. The I signal was used as a reference for normalization of each spectrum [3].

Figure 2. (a) Representative ToF-SIMS m/z spectra of dried Shewanella sp. biofilm deposited on clean Si wafer, hydrated biofilm, and uninoculated medium solution and (b) 2D images of m/z 225 (C_{14} FA)